74LVCH32373A

32-bit transparant D-type latch with 5 V tolerant inputs/outputs; 3-state

Rev. 5 — 17 December 2015

Product data sheet

1. General description

The 74LVCH32373A is a 32-bit transparent D-type latch featuring separate D-type inputs for each latch and 3-state outputs for <u>bus</u>-oriented applications. One latch enable input (nLE) and one output enable input (nOE) are provided for each octal. Inputs can be driven from either 3.3 V or 5 V devices.

The device consists of 4 sections of eight D-type transparent latches with 3-state true outputs. When input nLE is HIGH, data at the nDn inputs enter the latches. In this condition, the latches are transparent, i.e. a latch output changes each time its corresponding D-input changes.

When input nLE is LOW, the latches store the information that was present at the D-inputs one set-up time preceding the HIGH-to-LOW transition of nLE. When input nOE is LOW, the contents of the eight latches are available at the outputs. When input nOE is HIGH, the outputs go to the high-impedance OFF-state. Operation of the nOE input does not affect the state of the latches.

The inputs can be driven from either 3.3 V or 5 V devices. In 3-state operation, outputs can handle 5 V. These features allow the use of these devices in a mixed 3.3 V and 5 V environment.

Bus hold on data inputs eliminates the need for external pull-up resistors to hold unused inputs.

2. Features and benefits

- 5 V tolerant inputs/outputs for interfacing with 5 V logic
- Wide supply voltage range from 1.2 V to 3.6 V
- CMOS low power consumption
- Multibyte flow-through standard pinout architecture
- Multiple low inductance supply pins for minimum noise and ground bounce
- Direct interface with TTL levels
- All data inputs have bus hold
- High impedance when V_{CC} = 0 V
- Complies with JEDEC standard:
 - ◆ JESD8-7A (1.65 V to 1.95 V)
 - ◆ JESD8-5A (2.3 V to 2.7 V)
 - ◆ JESD8-C/JESD36 (2.7 V to 3.6 V)



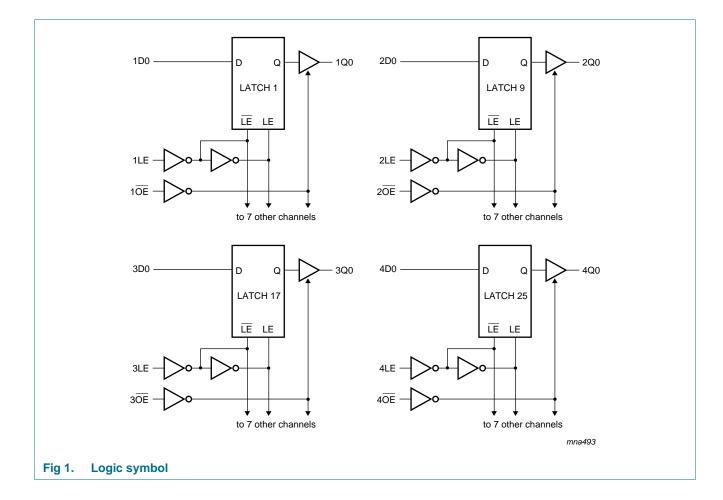
- ESD protection:
 - ◆ HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-B exceeds 200 V
 - ◆ CDM JESD22-C101E exceeds 1000 V
- Specified from -40 °C to +85 °C and -40 °C to +125 °C
- Packaged in plastic fine-pitch ball grid array package

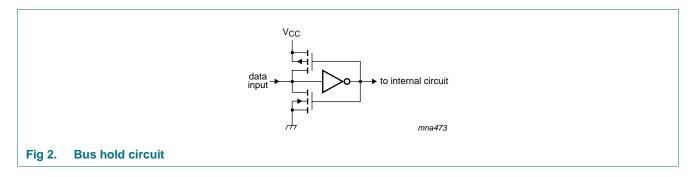
Ordering information

Table 1. **Ordering information**

Type number	Package							
	Temperature range	Name	Description	Version				
74LVCH32373AEC	–40 °C to +125 °C		plastic low profile fine-pitch ball grid array package; 96 balls; body 13.5 × 5.5 × 1.05 mm	SOT536-1				

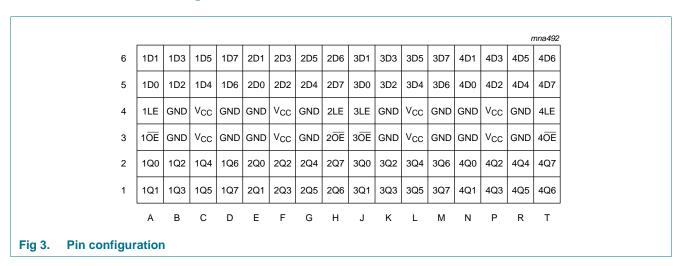
Functional diagram





5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Ball	Description
$n\overline{OE}$ (n = 1 to 4)	A3, H3, J3, T3	output enable input (active LOW)
nLE (n = 1 to 4)	A4, H4, J4, T4	latch enable input (active HIGH)
1D[0:7]	A5, A6, B5, B6, C5, C6, D5, D6	data input
2D[0:7]	E5, E6, F5, F6, G5, G6, H6, H5	data input
3D[0:7]	J5, J6, K5, K6, L5, L6, M5, M6	data input
4D[0:7]	N5, N6, P5, P6, R5, R6, T6, T5	data input
1Q[0:7]	A2, A1, B2, B1, C2, C1, D2, D1	data output
2Q[0:7]	E2, E1, F2, F1, G2, G1, H1, H2	data output
3Q[0:7]	J2, J1, K2, K1, L2, L1, M2, M1	data output
4Q[0:7]	N2, N1, P2, P1, R2, R1, T1, T2	data output
GND	B3, B4, D3, D4, E3, E4, G3, G4, K3, k M3, M4, N3, N4, R3, R4	(4, ground (0 V)
V _{CC}	C3, C4, F3, F4, L3, L4, P3, P4	supply voltage

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6. Functional description

Table 3. Function table[1]

The same of the sa				Internal latch	Output
	nOE nLE nDn		nDn		nQn
Enable and read register	L	Н	L	L	L
(transparent mode)	L	Н	Н	Н	Н
Latch and read register	L	L	I	L	L
	L	L	h	Н	Н
Latch register and disable	Н	L	I	L	Z
outputs	Н	L	h	Н	Z

^[1] H = HIGH voltage level;

h = HIGH voltage level one set-up time prior to the HIGH-to-LOW LE transition;

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+6.5	V
I _{IK}	input clamping current	V _I < 0 V		-50	-	mA
VI	input voltage		[1]	-0.5	+6.5	V
I _{OK}	output clamping current	$V_O > V_{CC}$ or $V_O < 0$ V		-	±50	mA
Vo	output voltage	output HIGH or LOW state	[2]	-0.5	V _{CC} + 0.5	V
		output 3-state	[2]	-0.5	+6.5	V
I _O	output current	$V_O = 0 V to V_{CC}$		-	±50	mA
I _{CC}	supply current			-	200	mA
I _{GND}	ground current			-200	-	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$	[3]	-	1000	mW

^[1] The minimum input voltage ratings may be exceeded if the input current ratings are observed.

L = LOW voltage level;

I = LOW voltage level one set-up time prior to the HIGH-to-LOW LE transition;

Z = High impedance OFF-state.

^[2] The output voltage ratings may be exceeded if the output current ratings are observed.

^[3] Above 70 °C, the value of P_{tot} derates linearly with 1.8 mW/K.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage		1.65	-	3.6	V
		functional	1.2	-	3.6	V
VI	input voltage		0	-	5.5	V
Vo	output voltage	output HIGH or LOW state	0	-	V_{CC}	V
		output 3-state	0	-	5.5	V
T _{amb}	ambient temperature	in free air	-40	-	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 1.65 V to 2.7 V	-	-	20	ns/V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	-	10	ns/V

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to +8	35 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
V _{IH}	HIGH-level	V _{CC} = 1.2 V	1.08	-	-	1.08	-	V
	input voltage	V _{CC} = 1.65 V to 1.95 V	$0.65 \times V_{CC}$	-	-	$0.65 \times V_{CC}$	-	V
		V _{CC} = 2.3 V to 2.7 V	1.7	-	-	1.7	-	V
		V _{CC} = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V
V_{IL}	LOW-level input voltage	V _{CC} = 1.2 V	-	-	0.12	-	0.12	V
		V _{CC} = 1.65 V to 1.95 V	-	-	$0.35 \times V_{CC}$	-	$0.35 \times V_{CC}$	V
		V _{CC} = 2.3 V to 2.7 V	-	-	0.7	-	0.7	V
		V _{CC} = 2.7 V to 3.6 V	-	-	0.8	-	0.8	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}						
		$I_O = -100 \mu A;$ $V_{CC} = 1.65 \text{ V to } 3.6 \text{ V}$	V _{CC} - 0.2	-	-	V _{CC} - 0.3	-	V
		$I_O = -4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.2	-	-	1.05	-	V
		$I_{O} = -8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.8	-	-	1.65	-	V
		$I_{O} = -12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	2.2	-	-	2.05	-	V
		$I_{O} = -18 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.4	-	-	2.25	-	V
		$I_{O} = -24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.2	-	-	2.0	-	V
V_{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL}						
	output voltage	$I_O = 100 \mu A;$ $V_{CC} = 1.65 \text{ V to } 3.6 \text{ V}$	-	-	0.2	-	0.3	V
		$I_O = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.45	-	0.65	V
		$I_{O} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.6	-	0.8	V
		$I_O = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.4	-	0.6	V
		$I_O = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.55	-	0.8	V
Ι _Ι	input leakage current	V _{CC} = 3.6 V; V _I = 5.5 V or GND[2]	-	±0.1	±5	-	±20	μΑ

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 Table 6.
 Static characteristics ...continued

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to +8	35 °C	-40 °C to	o +125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
l _{OZ}	OFF-state output current	$V_I = V_{IH} \text{ or } V_{IL}; V_{CC} = 3.6 \text{ V};$ $V_O = 5.5 \text{ V or GND}^{[2]}$	-	±0.1	±5	-	±20	μΑ
I _{OFF}	power-off leakage current	$V_{CC} = 0 \text{ V}; V_1 \text{ or } V_0 = 5.5 \text{ V}$	-	±0.1	±10	-	±20	μΑ
I _{CC}	supply current	$V_{CC} = 3.6 \text{ V}; V_I = V_{CC} \text{ or GND};$ $I_O = 0 \text{ A}$	-	0.1	40	-	160	μА
ΔI_{CC}	additional supply current	per input pin; $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V};$ $V_I = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A}$	-	5	500	-	5000	μΑ
Cı	input capacitance	$V_{CC} = 0 \text{ V to } 3.6 \text{ V};$ $V_I = \text{GND to } V_{CC}$	-	5.0	-	-	-	pF
I _{BHL}	bus hold LOW current	$V_{CC} = 1.65; V_I = 0.58 V_{3[4]}$	10	-	-	10	-	μΑ
		$V_{CC} = 2.3; V_I = 0.7 V$	30	-	-	25	-	μΑ
		$V_{CC} = 3.0; V_I = 0.8 \text{ V}$	75	-	-	60	-	μΑ
I _{BHH}	bus hold	$V_{CC} = 1.65; V_I = 1.07 V_{3[4]}$	-10	-	-	-10	-	μΑ
	HIGH current	V _{CC} = 2.3; V _I = 1.7 V	-30	-	-	-25	-	μΑ
		$V_{CC} = 3.0; V_I = 2.0 \text{ V}$	-75	-	-	-60	-	μΑ
I _{BHLO}	bus hold	$V_{CC} = 1.95 V_{\frac{[3][5]}{2}}$	200	-	-	200	-	μΑ
	LOW overdrive	V _{CC} = 2.7 V	300	-	-	300	-	μΑ
	current	V _{CC} = 3.6 V	500	-	-	500	-	μΑ
I _{BHHO}	bus hold	V _{CC} = 1.95 V[3][5]	-200	-	-	-200	-	μΑ
	HIGH	V _{CC} = 2.7 V	-300	-	-	-300	-	μА
	overdrive current	V _{CC} = 3.6 V	-500	-	-	-500	-	μΑ

- [1] All typical values are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.
- [2] The bus hold circuit is switched off when $V_I > V_{CC}$ allowing 5.5 V on the input pin.
- [3] Valid for data inputs only. Control inputs do not have a bus hold circuit.
- [4] The specified sustaining current at the data input holds the input below the specified V_I level.
- [5] The specified overdrive current at the data input forces the data input to the opposite logic input state.

10. Dynamic characteristics

Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 8.

Symbol	Parameter	Conditions	Conditions		$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$			-40 °C to +125 °C	
				Min	Typ[1]	Max	Min	Max	
t _{pd}	propagation	Dn to Qn; see Figure 4	[2]						
	delay	V _{CC} = 1.2 V		-	12	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		1.5	5.4	11.4	1.5	13.2	ns
		V _{CC} = 2.3 V to 2.7 V		1.0	2.9	5.7	1.0	6.6	ns
		V _{CC} = 2.7 V		1.5	2.9	4.9	1.5	6.5	ns
		V _{CC} = 3.0 V to 3.6 V		1.0	2.4	4.4	1.0	5.9	ns
		LE to Qn; see Figure 5							
		V _{CC} = 1.2 V		-	14	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		2.0	6.4	12.4	2.0	14.4	ns
		V _{CC} = 2.3 V to 2.7 V		1.5	3.4	6.1	1.5	7.1	ns
		V _{CC} = 2.7 V		1.5	3.0	5.3	1.5	7.0	ns
		V _{CC} = 3.0 V to 3.6 V		1.5	2.9	4.8	1.5	6.0	ns
t _{en}	enable time	OE to Qn; see Figure 7	[2]						
		V _{CC} = 1.2 V		-	18	-	-	-	ns
		V _{CC} = 1.65 V to 1.95 V		1.5	5.5	12.4	1.5	14.3	ns
		V _{CC} = 2.3 V to 2.7 V		1.0	3.1	6.6	1.0	7.6	ns
		V _{CC} = 2.7 V		1.5	3.3	5.7	1.5	7.5	ns
		V _{CC} = 3.0 V to 3.6 V		1.0	2.5	4.9	1.0	6.5	ns
t _{dis}	disable time	OE to Qn; see Figure 7	[2]						
		V _{CC} = 1.2 V		-	11	-	-	-	ns
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		2.8	4.5	9.1	2.8	10.5	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		1.0	2.5	5.1	1.0	6.0	ns
		$V_{CC} = 2.7 \text{ V}$		1.5	3.3	6.3	1.5	8.0	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		1.5	3.1	5.4	1.5	7.0	ns
t _W	pulse width	LE HIGH; see Figure 5							
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		5.0	-	-	5.0	-	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		4.0	-	-	4.0	-	ns
		$V_{CC} = 2.7 \text{ V}$		3.0	-	-	3.0	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		3.0	2.0	-	3.0	-	ns
t _{su}	set-up time	Dn to LE; see Figure 6							
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		3.0	-	-	3.0	-	ns
		V _{CC} = 2.3 V to 2.7 V		2.5	-	-	2.5	-	ns
		V _{CC} = 2.7 V		2.0	-	-	2.0	-	ns
ı		V _{CC} = 3.0 V to 3.6 V		2.0	1.0	-	2.0	-	ns

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Table 7. Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 8.

Symbol	Parameter Conditions		T _{amb} =	–40 °C to	+85 °C	-40 °C to +125 °C		Unit	
					Typ[1]	Max	Min	Max	
t _h	hold time	Dn to LE; see Figure 6							
		V _{CC} = 1.65 V to 1.95 V		2.5	-	-	2.5	-	ns
		V _{CC} = 2.3 V to 2.7 V		2.0	-	-	2.0	-	ns
		V _{CC} = 2.7 V		0.9	-	-	0.9	-	ns
		V _{CC} = 3.0 V to 3.6 V		+0.9	-1.0	-	0.9	-	ns
t _{sk(o)}	output skew time	V _{CC} = 3.0 V to 3.6 V	[3]	-	-	1.0	-	1.5	ns
C _{PD}	power	per input; V _I = GND to V _{CC}	[4]						
	dissipation capacitance	V _{CC} = 1.65 V to 1.95 V		-	10.8	-	-	-	pF
		V _{CC} = 2.3 V to 2.7 V		-	13.0	-	-	-	pF
		V _{CC} = 3.0 V to 3.6 V		-	15.0	-	-	-	pF

- [1] Typical values are measured at $T_{amb} = 25$ °C and $V_{CC} = 1.2$ V, 1.8 V, 2.5 V 2.7 V and 3.3 V respectively.
- [2] t_{pd} is the same as t_{PLH} and t_{PHL} .
 - ten is the same as tPZL and tPZH.
 - t_{dis} is the same as t_{PLZ} and t_{PHZ} .
- [3] Skew between any two outputs of the same package switching in the same direction. This parameter is guaranteed by design.
- [4] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).
 - $P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$ where:

 f_i = input frequency in MHz; f_0 = output frequency in MHz

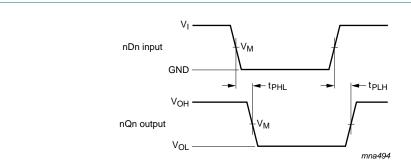
 C_L = output load capacitance in pF

V_{CC} = supply voltage in Volts

N = number of inputs switching

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs

11. Waveforms



Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig 4. Input (nDn) to output (nQn) propagation delay times

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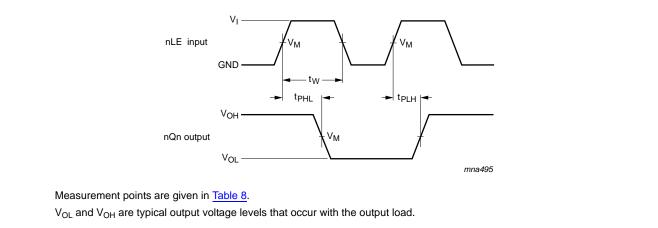


Fig 5. Latch enable input (nLE) pulse width, the latch enable input to outputs (nQn) propagation delay times

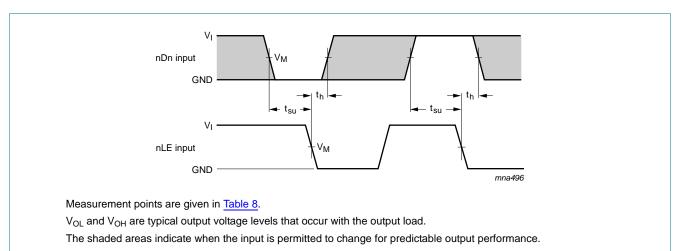


Fig 6. Set-up and hold times for inputs (nDn) to inputs (nLE)

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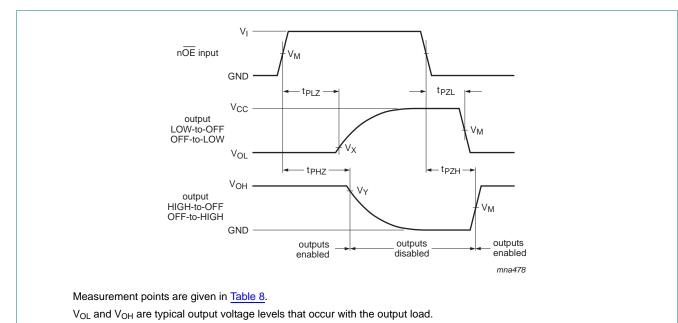
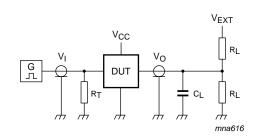


Fig 7. 3-state output enable and disable times

Table 8. Measurement points

Supply voltage					
V _{CC}	VI	V _M	V _M	V _X	V _Y
1.2 V	V _{CC}	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	V _{OL} + 0.15 V	V _{OH} – 0.15 V
1.65 V to 1.95 V	V _{CC}	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	V _{OL} + 0.15 V	V _{OH} – 0.15 V
2.3 V to 2.7 V	V _{CC}	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$	V _{OL} + 0.15 V	V _{OH} – 0.15 V
2.7 V	2.7 V	1.5 V	1.5 V	V _{OL} + 0.3 V	$V_{OH} - 0.3 V$
3.0 V to 3.6 V	2.7 V	1.5 V	1.5 V	V _{OL} + 0.3 V	V _{OH} – 0.3 V



Test data is given in $\underline{\text{Table 9}}$. Definitions for test circuit:

R_L = Load resistance.

C_L = Load capacitance including jig and probe capacitance

 R_T = Termination resistance should be equal to the output impedance Z_0 of the pulse generator.

Fig 8. Test circuit for measuring switching times

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Table 9. Test data

Supply voltage	Input		Load	Load		V _{EXT}			
	VI	t _r , t _f	CL	R _L	t _{PLH} , t _{PHL}	t _{PLZ} , t _{PZL}	t _{PHZ} , t _{PZH}		
1.2 V	V _{CC}	≤ 2 ns	30 pF	1 kΩ	open	$2 \times V_{CC}$	GND		
1.65 V to 1.95 V	V _{CC}	≤ 2 ns	30 pF	1 kΩ	open	$2 \times V_{CC}$	GND		
2.3 V to 2.7 V	V _{CC}	≤ 2 ns	30 pF	500 Ω	open	$2 \times V_{CC}$	GND		
2.7 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open	2 × V _{CC}	GND		
3.0 V to 3.6 V	2.7 V	≤ 2.5 ns	50 pF	500 Ω	open	2 × V _{CC}	GND		

12. Package outline

LFBGA96: plastic low profile fine-pitch ball grid array package; 96 balls; body 13.5 x 5.5 x 1.05 mm SOT536-1

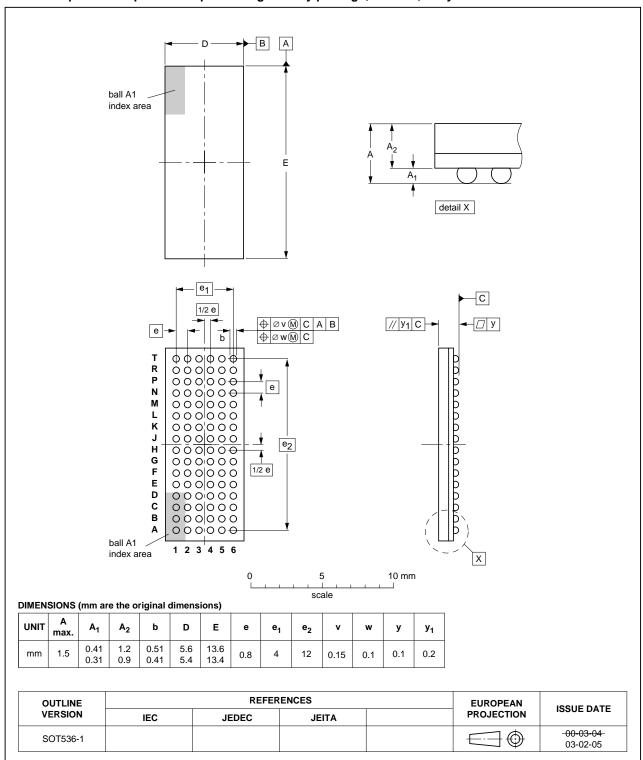


Fig 9. Package outline SOT536-1 (LFBGA96)

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13. Abbreviations

Table 10. Abbreviations

Acronym	Description		
CDM	Charged Device Model		
DUT	Device Under Test		
ESD	ElectroStatic Discharge		
HBM	Human Body Model		
MM	Machine Model		
TTL	Transistor-Transistor Logic		

14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
74LVCH32373A v.5	20151217	Product data sheet	-	74LVCH32373A v.4	
Modifications:	<u>Table 1</u> : Ordering info corrected (errata).				
74LVCH32373A v.4	20130128	Product data sheet	-	74LVCH32373A v.3	
Modifications:	Features list corrected (errata).				
74LVCH32373A v.3	20130122	Product data sheet	-	74LVCH32373A v.2	
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. 				
	 Legal texts have been adapted to the new company name where appropriate. 				
	• <u>Table 4</u> , <u>Table 5</u> , <u>Table 6</u> , <u>Table 7</u> , <u>Table 8</u> and <u>Table 9</u> : values added for lower voltage ranges.				
74LVCH32373A v.2	20040519	Product specification	-	74LVCH32373A v.1	
74LVCH32373A v.1	19991124	Product specification	-	-	

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15. Legal information

15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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